Search Notes



Appl	icati	ion/	Con	trol	No.

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Applicant(s)/Patent Under Reexamination

TANAKA ET AL.

Examiner

Art Unit

Sheela J Huff

1643

	SEARCHED		
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SEARCH NOTES			
Search Notes	Date	Examiner	
inventor serach on PALNM	10/21/08	sjh	
SCORE- SEQ ID NO. 2 and 3	10/21/08	sjh	
Stic structure search	10/21/08	sjh	
WEST-insert	10/21/08	sjh	
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WEST-insert	4/7/09	sjh	
EAST-insert	9/14/09	sjh	

INTERFERENCE SEARCH				
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